Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/615,327	LEE ET AL.		
Examiner	Art Unit		
Jennifer K. Michener	1762		

	0540	CUED		
	SEARCHED			
Class	Subclass	Date	Examiner	
427	180,243	6/12/2005	JKM	
427	245,247	6/12/2005	JKM	
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SEARCH NO (INCLUDING SEARCH	TES ISTRATEGY)
	DATE	EXMR
EAST search strategy attached	6/12/2005	JKM
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